

SSP7200N-VB Datasheet

N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	200					
$R_{DS(on)}$ Typ. (Ω) at $V_{GS} = 10 \text{ V}$	0.038					
$R_{DS(on)}$ Typ. (Ω) at $V_{GS} = 7.5 \text{ V}$	0.043					
Q _g typ. (nC)	20					
I _D (A)	30					
Configuration	Single					

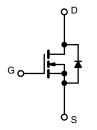
FEATURES

- \bullet Thunder technology optimizes balance of $R_{DS(on)},\,Q_g,\,Q_{sw}$ and Q_{oss}
- 100 % R_q and UIS tested

RoHS COMPLIANT HALOGEN FREE

APPLICATIONS

- Fixed telecom
- DC/DC converter
- Primary and secondary side switch
- Synchronous rectification
- LED lighting
- Power supplies
- Class D amplifier



N-Channel MOSFET

DI	FN5X6			
Top View	Bottom View	Тор	Top View	
	IN1	S [1 ● S [2 S [3 G [4	8 D 7 D 6 D 5 D	

PARAMETER Drain-source voltage		SYMBOL	LIMIT	UNIT	
		V _{DS}	200		
Gate-source voltage		V _{GS}	± 20	V	
	T _C = 25 °C		30		
Continuous dunin suurent (T. 150 °C)	T _C = 70 °C	1 . [23		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	I _D	7.6 ^{b, c}		
	T _A = 70 °C	1 [5.9 ^{b, c}	Α	
Pulsed drain current (t = 100 µs)		I _{DM}	70		
Continuous source-drain diode current	T _C = 25 °C		30		
	T _A = 25 °C	l _s	5.6 ^{b, c}		
Single pulse avalanche current		I _{AS}	30		
Single pulse avalanche energy L = 0.1 mH		E _{AS}	45	mJ	
	T _C = 25 °C		104		
Nancias de la cinatia de	T _C = 70 °C	1 5 [66.6	14/	
Maximum power dissipation	T _A = 25 °C	P _D	6.25 ^{b, c}	W	
	T _A = 70 °C	†	4 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150		
Soldering recommendations (peak temperature) c			260	°C	

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient ^b	t ≤ 10 s	R _{thJA}	15	20	°C/W		
Maximum junction-to-case (drain)	Steady state	R _{thJC}	0.9	1.2	C/VV		

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The DFN5x 6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 54 °C/W.
- g. $T_C = 25$ °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static			l			•
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	200	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	173	-	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-7.1	-	mV/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA
Zana alian alian adalah an arad		V _{DS} = 200 V, V _{GS} = 0 V	-	-	1	_
Zero gate voltage drain current	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	μA
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	30	-	-	Α
Duning and the second of the s	Б	V _{GS} =10 V, I _D = 10 A	-	0.038	-	
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 10 A	-	0.043	-	Ω
Forward transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 10 \text{ A}$	-	27	-	S
Dynamic ^b						
Input capacitance	C _{iss}		-	1380	-	
Output capacitance	C _{oss}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	142	-	pF
Reverse transfer capacitance	C _{rss}		-	11	ï	
Total gate charge	Qg	V _{DS} = 100 V, V _{GS} = 10 V, I _D = 10 A	-	25	38	nC
			-	20	30	
Gate-source charge	Q _{gs}	$V_{DS} = 100 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	6.4	-	
Gate-drain charge	Q _{gd}		-	6.8	-	
Output charge	Q _{oss}	V _{DS} = 100 V, V _{GS} = 0 V	-	52	-	1
Gate resistance	R_g	f = 1 MHz	0.6	2.1	4	Ω
Turn-on delay time	t _{d(on)}		-	9	18	
Rise time	t _r	$V_{DD} = 100 \text{ V}, R_{I} = 10 \Omega, I_{D} \cong 10 \text{ A},$	-	20	40	
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	20	40	
Fall time	t _f		-	24	48	Ī
Turn-on delay time	t _{d(on)}		-	11	22	ns
Rise time	t _r	V_{DD} = 100 V, R_L = 10 Ω , $I_D \cong$ 10 A,	-	27	54	
Turn-off delay time	t _{d(off)}	V_{GEN} = 7.5 V, R_g = 1 Ω	-	18	36	
Fall time	t _f		-	24	48	
Drain-Source Body Diode Characteristi	cs					
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	35.4	_
Pulse diode forward current	I _{SM}		-	-	80	A
Body diode voltage	V_{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.77	1.1	V
Body diode reverse recovery time	t _{rr}		-	100	200	ns
Body diode reverse recovery charge	Q _{rr}	1 10 A dl/dt 100 A/ T 05 00	-	400	800	nC
Reverse recovery fall time	ta	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	80	-	,
Reverse recovery rise time	t _b	7		20	-	ns

Notes

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- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

0.055

0.050

0.045

0.040

0.035

0.030

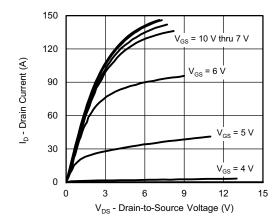
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R_{DS(on)} - On-Resistance (Ω)



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Output Characteristics

 $V_{GS} = 7.5 \text{ V}$



On-Resistance vs. Drain Current and Gate Voltage

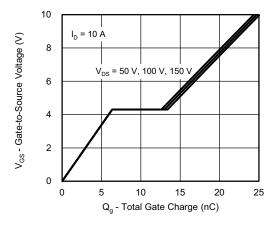
I_D - Drain Current (A)

48

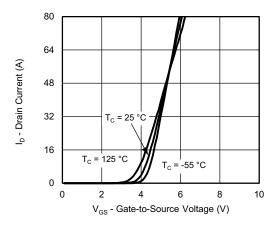
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80

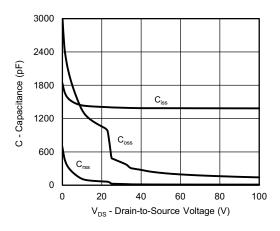
32



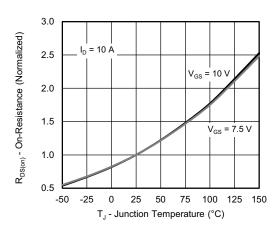
Gate Charge



Transfer Characteristics



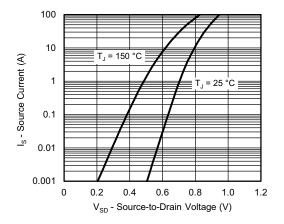
Capacitance



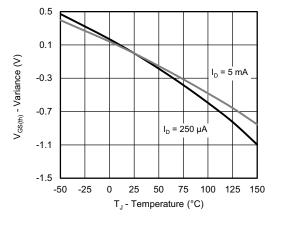
On-Resistance vs. Junction Temperature



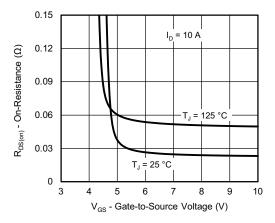
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



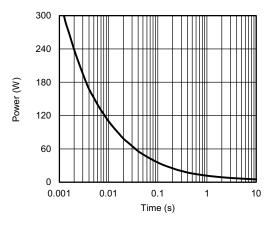
Source-Drain Diode Forward Voltage



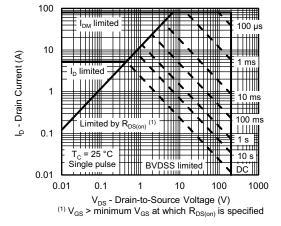
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



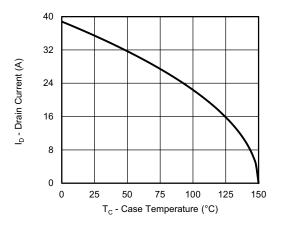
Single Pulse Power, Junction-to-Ambient



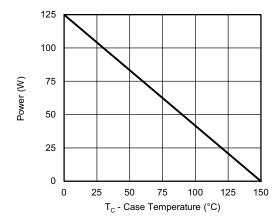
Safe Operating Area, Junction-to-Ambient

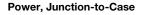


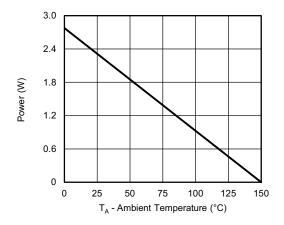
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating a







Power, Junction-to-Ambient

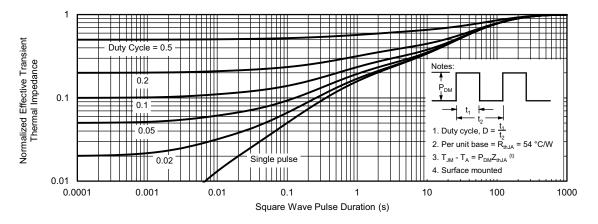
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

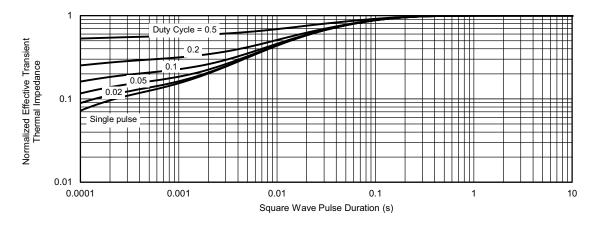
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



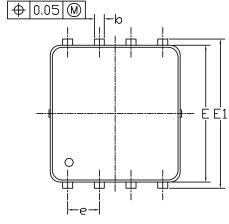
Normalized Thermal Transient Impedance, Junction-to-Ambient

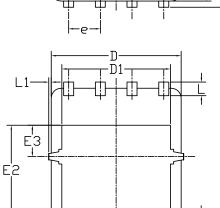


Normalized Thermal Transient Impedance, Junction-to-Case

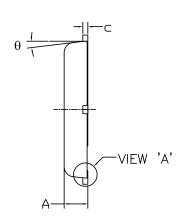


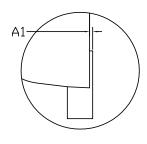
DFN5x6_8L_EP1_P PACKAGE OUTLIN





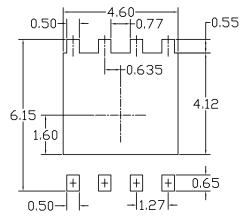
BOTTOM VIEW





<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



	DIMENSIONS IN MILLIMETERS DIMENSION					CHEC
SYMBOLS				DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.85	0. 95	1.00	0.033	0.037	0.039
A1	0.00		0.05	0.000		0.002
b	0.30	0.40	0.50	0.012	0.016	0.020
С	0.15	0. 20	0. 25	0.006	0.008	0.010
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242
E2	3. 525	3. 625	3. 725	0. 139	0. 143	0. 147
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054
e	e 1. 27 BSC			0. 050 BSC		
L	0.45	0. 55	0.65	0.018	0.022	0.026
L1	0		0.15	0		0.006
L2	L2 0. 68 REF			0.027 REF		
θ	0°		10°	0°		10°

NOTE

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm



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